

## **IGBT Chip in NPT-technology**

#### Features:

- 1200V NPT technology
- positive temperature coefficient
- easy paralleling

### This chip is used for:

 power module BUP 213

### **Applications:**

drives



Chip Type	<b>V</b> <sub>CE</sub>	<b>I</b> c	Die Size	Package
SIGC25T120C	1200V	15A	4.53 x 5.71 mm <sup>2</sup>	sawn on foil

### **Mechanical Parameter**

Raster size	4.53 x 5.71			
Emitter pad size	2 x ( 2.18 x 1.6 )	mm <sup>2</sup>		
Gate pad size	1.09 x 0.68			
Area total	25.9			
Thickness	200	μm		
Wafer size	150	mm		
Max.possible chips per wafer	555			
Passivation frontside	Photoimide			
Pad metal	3200 nm AlSiCu			
Backside metal	Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	Electrically conductive glue or solder			
Wire bond	Al, <500μm			
Reject ink dot size	Ø 0.65mm ; max 1.2mm			
Recommended storage environment	Store in original container, in dry nitrogen, in dark environment, < 6 month at an ambient temperature of 23°C			

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## **Maximum Ratings**

Parameter	Symbol	Value	Unit
Collector-Emitter voltage, $T_{vj}$ =25 °C	V <sub>CE</sub>	1200	V
DC collector current, limited by $T_{\rm vj\;max}$	I <sub>C</sub>	1)	Α
Pulsed collector current, $t_p$ limited by $T_{vj max}$	$I_{c,puls}$	45	Α
Gate emitter voltage	V <sub>GE</sub>	±20	V
Junction temperature range	$T_{vj}$	-55 +175	°C
Operating junction temperature	$T_{\rm vj}$	-55+150	°C
Short circuit data $^2$ $V_{GE} = 15V$ , $V_{CC} = 900V$ , $T_{vj} = 150$ °C	tsc	10	μs
Reverse bias safe operating area <sup>2)</sup> (RBSOA)	I <sub>C,max</sub>	= 30A, $V_{CE,max} = 1200$ \ $T_{vj} \le 150$ °C	/

<sup>1)</sup> depending on thermal properties of assembly

## Static Characteristic (tested on wafer), $T_{\rm vj}$ =25 °C

Parameter	Symbol	Conditions	Value			Unit
i didilictei			max.			
Collector-Emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{\rm GE}$ =0V , $I_{\rm C}$ = 1mA	1200			
Collector-Emitter saturation voltage	V <sub>CEsat</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =15A	2.0	2.5	3.0	V
Gate-Emitter threshold voltage	$V_{\rm GE(th)}$	$I_{\rm C}$ =0.6mA , $V_{\rm GE}$ = $V_{\rm CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1200V , V <sub>GE</sub> =0V			1.9	μA
Gate-Emitter leakage current	I <sub>GES</sub>	$V_{\text{CE}}$ =0V , $V_{\text{GE}}$ =20V			480	nA
Integrated gate resistor	$r_{\rm G}$			none		Ω

# Dynamic Characteristic (not subject to production test - verified by design / characterization),

*T*<sub>vj</sub> =25 °C

Parameter	Symbol	Conditions	Value			Unit
raiametei	Syllibol	Conditions	min.	typ.	max.	Oilit
Input capacitance	Cies	$V_{CE}=25V$ ,		1000		
Output capacitance	Coes	$V_{GE}=0V$ ,		150		pF
Reverse transfer capacitance	C <sub>res</sub>	f=1MHz		70		

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<sup>&</sup>lt;sup>2)</sup> not subject to production test - verified by design/characterization

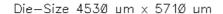


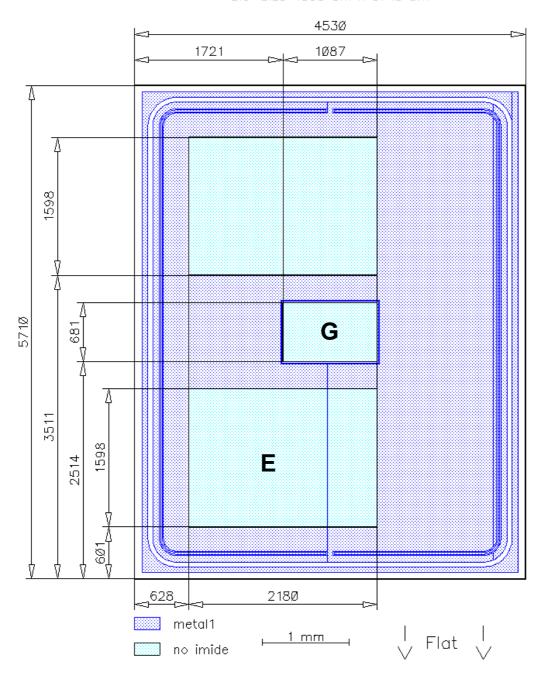
### **Further Electrical Characteristic**

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.



### **Chip Drawing**





E = Emitter pad

**G** = Gate pad



#### Description

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

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